

<b>Notice of References Cited</b>	Application/Control No. 10/643,081	Applicant(s)/Patent Under Reexamination UEJIMA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0187379	12-2002	Yasuo et al.	429/34
	C	US-			
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	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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